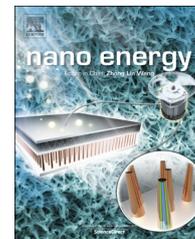




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RAPID COMMUNICATION

# Simulation method for optimizing the performance of an integrated triboelectric nanogenerator energy harvesting system



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## KEYWORDS

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## Abstract

Demonstrating integrated triboelectric nanogenerator energy harvesting systems that contain triboelectric nanogenerators, power management circuits, signal processing circuits, energy storage elements, and/or load circuits are core steps for practical applications of triboelectric nanogenerators. Through the design flow of such systems, theoretical simulation plays a critical role. In this manuscript, we provided a new theoretical simulation method for integrated triboelectric nanogenerator systems through integrating the equivalent circuit model of triboelectric nanogenerators into SPICE software. This new simulation method was validated by comparing its results with analytical solutions in some specific triboelectric nanogenerator systems. Finally, we employed this new simulator to analyze the performance of an integrated triboelectric nanogenerator system with a power management circuit. From the study of the influence of different circuit parameters, we outline the design strategy for such kind of triboelectric nanogenerator systems.

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## Introduction

Scavenging ambient mechanical energy from the environment has long been considered as a critical research topic [1-5]. Recently, triboelectric nanogenerators (TENGs) based

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on contact electrification [6-8] and electrostatic induction emerge as a promising technology of mechanical energy harvesting, especially for powering portable electronics [9-14] or working as self-powered sensors [15]. Similar to the development of CMOS integrated circuits and systems, the fully-integrated energy harvesting systems that contain TENGs, power management circuits, signal processing circuits, energy storage elements, and/or load circuits are essential for the practical applications of the TENGs. Theoretical simulation plays a key role in understanding the working mechanism and analyzing the output performance of the TENGs, which paves the way for future design and optimization of the entire system. In this regard, a few efforts have been made to carry out the numerical calculations and analytical studies on the output characteristics of the TENG unit with various working modes [16-19]. However, all the prior investigations merely focus on the behavior of TENG itself, or simply with linear resistive load circuits, while the even more complex analysis with practical load circuits that contain arbitrary numbers of linear and non-linear components could hardly be accomplished by the currently-established simulation approaches. Therefore, a new simulation method of TENGs is highly desired to solve the challenges in the calculations of practical energy harvesting systems.

In this manuscript, the first equivalent circuit model of TENGs was derived to deepen the understanding of their core physics and assist their simulation process. Then the first simulator of an entire TENG system was built by integrating the TENG equivalent circuit model into circuit design software (commonly called SPICE software). The effectiveness of this simulator was validated by comparing its results with analytical solutions in some specific triboelectric nanogenerator systems. Then to show the potential application of this powerful new method, we studied the performance of a TENG with a power management system and outlined the strategy for the design of such system for optimum performance. The new TENG simulator demonstrated in this paper is not only a standard tool for theoretically analyzing the output characteristics of TENGs in any complex systems, but also provides a novel approach for optimum design of the TENG-based energy harvesting systems. This research will lead to fast development of the TENG's performance, and accelerate the process for its practical applications and commercialization.

## Results and discussion

As a common sense, the equivalent circuit model is one of the most important theoretical understandings of an electronic device. Similar to the Ebers-Moll model (EM model) [20] of bipolar transistors that is derived from their governing equation, the equivalent circuit model of TENGs can also be derived from their governing equation ( $V$ - $Q$ - $x$  relationship), as shown below [16,17]

$$V = -\frac{1}{C_{\text{TENG}}}Q + V_{\text{OC}} \quad (1)$$

From Eq. (1), there are two terms at the right side, which can be represented by two circuit elements in the equivalent circuit model. The first one is a capacitance term, which is originated from the capacitance between the two electrodes and can be represented by a capacitor ( $C_{\text{TENG}}$ ).

The other is an open-circuit voltage term, which is originated from the separation of the polarized tribo-charges and can be represented by an ideal voltage source ( $V_{\text{OC}}$ ). In combination of these two, the whole equivalent circuit model can be represented by a serial connection of an ideal voltage source and a capacitor, as shown in Figure 1.

The above equivalent circuit model is very helpful to understand the core physics of TENGs. For example, the optimum resistance [16] and three-working-region behavior [16] can be easily understood from this equivalent circuit model, which is inherently because of the impedance match between  $C_{\text{TENG}}$  and the load resistance. The inherent capacitance of TENG will show impedance to the AC voltage source  $V_{\text{OC}}$ . Any structural parameters that will increase this inherent capacitance will lower this impedance and thus lower the matched resistance. Increasing the velocity of motion is equivalent of increasing the frequency of the AC voltage source  $V_{\text{OC}}$  so the matched resistance will also be lowered. Since the impedance of  $C_{\text{TENG}}$  is independent of the tribo-charge density, the matched load resistance is also not affected by the tribo-charge density.

This equivalent circuit model extraction is also the first step of building this new TENG simulator. After the equivalent circuit model is obtained, the values of the ideal voltage source and the capacitance in the above equivalent circuit model need to be specified to complete this integration to the SPICE software. From the basic electrodynamics theory, both  $V_{\text{OC}}$  and  $C_{\text{TENG}}$  are only functions of the moving distance ( $x$ ) and structural parameters while independent of motion parameters, such as velocity and acceleration [16-19]. Two methods are currently developed to specify the  $V_{\text{OC}}-x$  and  $C_{\text{TENG}}-x$  relationships. Analytical derivation is a preferred method but it only works for certain geometry features such as parallel plate contact-mode or sliding-mode TENGs. A more general method which works for all TENGs is numerical calculation based on finite element method (FEM). In this method, the value of  $V_{\text{OC}}$  and  $C_{\text{TENG}}$  is first obtained at certain values of  $x$ . Then, from continuous fraction interpolation, a numerical  $V_{\text{OC}}-x$  and  $C_{\text{TENG}}-x$  relationship can be generated in the entire  $x$  region.

Now the TENG can be embedded into the SPICE software as a basic element consisting of a voltage source in serial connection with a capacitor. To simulate the whole system in SPICE, several other steps are needed, including inserting other circuit elements, specifying the  $x(t)$  relationship that represents the mechanical motion input, as well as initializing

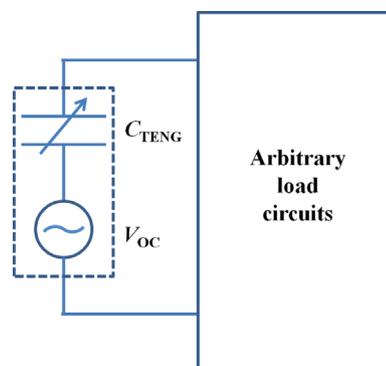


Figure 1 Equivalent circuit model of a triboelectric nanogenerator.

the storage elements. For example, residue charges of triboelectric nanogenerators at initial condition ( $t=0$ ) can be represented by the initial voltage across the capacitor  $C_{TENG}$ .

After the system is set in SPICE, the transit analysis of the TENG system can be performed. To validate the results from the SPICE software, we started with some TENG systems that can be solved analytically and the comparison of the results obtained from both methods is shown in Figure 2.

The first example is a parallel plate sliding-mode triboelectric nanogenerator loaded with a resistor. The parameters utilized in this calculation are listed in Table 1. The top plate of this triboelectric nanogenerator is under a constant velocity condition with the maximum moving distance within the range of the bottom plate and the motion process is shown below.

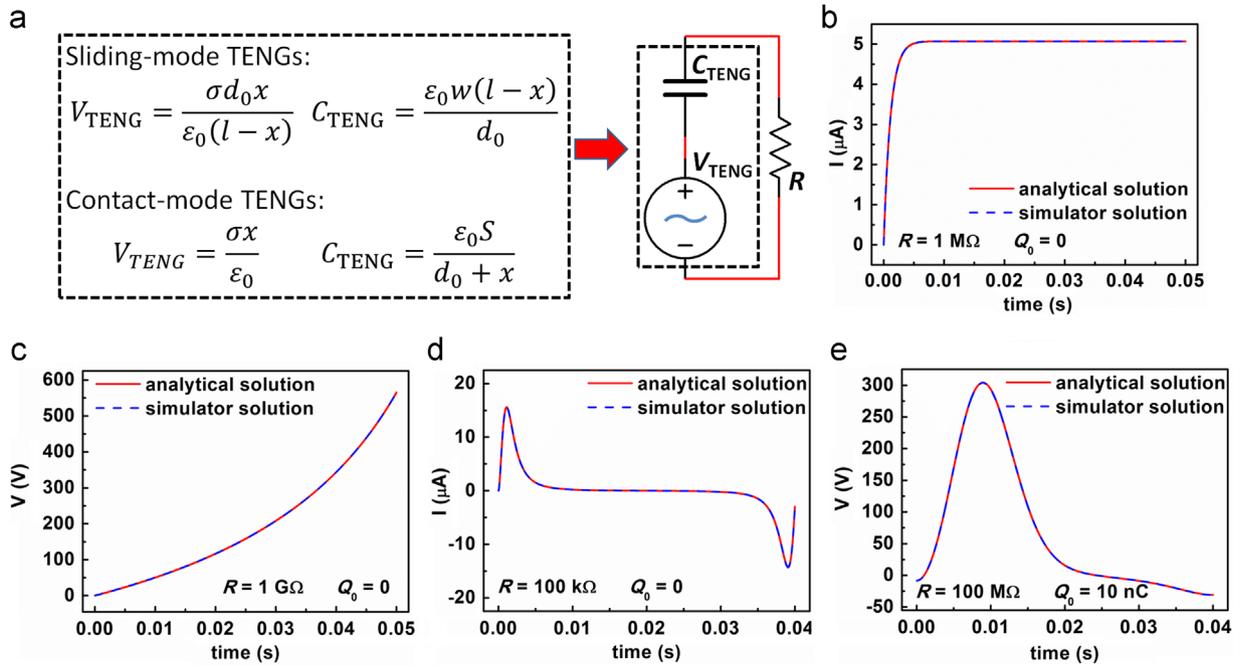
$$x = vt \left( t \leq \frac{x_{\max}}{v} \right) \quad (2)$$

From our previous analysis, the governing equation of this whole system combining the TENG and the resistor can be given as [17]:

$$R \frac{dQ}{dt} = V = -\frac{1}{C_{TENG}} Q + V_{OC} = -\frac{d_0}{w\epsilon_0(l-x)} Q + \frac{\sigma d_0 x}{\epsilon_0(l-x)} \quad (3)$$

With the boundary condition of  $Q(t=0)=Q_0$  (the initial charges on the plates of triboelectric nanogenerators are  $Q_0$ ), the output voltage and current of the resistor can be obtained analytically by solving the above differential equation, as shown below [17]:

$$I = \sigma w v \frac{d_0}{R w \epsilon_0 v - d_0} \left\{ \frac{l}{l-vt} \exp \left[ \frac{d_0}{R w \epsilon_0 v} \ln \left( \frac{l-vt}{l} \right) \right] - 1 \right\} - Q_0 \exp \left[ \frac{d_0}{R w \epsilon_0 v} \ln \left( \frac{l-vt}{l} \right) \right] \frac{d_0}{R w \epsilon_0 (l-vt)} \quad \left( t \leq \frac{x_{\max}}{v} \right) \quad (4)$$



**Figure 2** Verification of the built simulator. (a) Equations of contact and sliding-mode TENGs and equivalent circuits for the whole TENG system loaded by a resistor (b-e) Comparisons of outputs from the simulator and analytical equation. (b) Current output comparison under 1 MΩ load and  $Q_0=0$  conditions for the sliding-mode TENG. (c) Voltage output comparison under 1 GΩ load and  $Q_0=0$  conditions for the sliding-mode TENG. (d) Current output comparison under 100 kΩ load and  $Q_0=0$  conditions for the contact-mode TENG. (e) Voltage output comparison under 100 MΩ load and  $Q_0=10$  nC conditions for the contact-mode TENG.

**Table 1** Parameters of the TENGs utilized to validate the new simulator.

	Sliding-mode TENG	Contact-mode TENG
Dielectric 1	$\epsilon_{r1}=4, d_1=125 \mu\text{m}$	$\epsilon_{r1}=3.4, d_1=125 \mu\text{m}$
Dielectric 2	Metal, $d_2=0 \mu\text{m}$	Metal, $d_2=0 \mu\text{m}$
Effective dielectric thickness	$d_0=d_1/\epsilon_{r1}+d_2/\epsilon_{r2}=31.25 \mu\text{m}$	$d_0=d_1/\epsilon_{r1}+d_2/\epsilon_{r2}=36.76 \mu\text{m}$
Width of dielectrics $w$	0.05 m	0.05 m
Length of dielectrics $l$	0.08 m	0.1 m
Tribo-charge surface density $\sigma$	$100 \mu\text{Cm}^{-2}$	$8 \mu\text{Cm}^{-2}$
Maximum separation distance $x_{\max}$	0.05 m	0.002 m
Velocity $v$	$1 \text{ms}^{-1}$	$0.1 \text{ms}^{-1}$

$$V = \sigma w v R \frac{d_0}{R w \epsilon_0 v - d_0} \left\{ \frac{l}{l - vt} \exp \left[ \frac{d_0}{R w \epsilon_0 v} \ln \left( \frac{l - vt}{l} \right) \right] - 1 \right\} - Q_0 \exp \left[ \frac{d_0}{R w \epsilon_0 v} \ln \left( \frac{l - vt}{l} \right) \right] \frac{d_0}{w \epsilon_0 (l - vt)} \quad (t \leq \frac{x_{\max}}{v}) \quad (5)$$

Real-time outputs from the simulator for some specific values for  $R$  and  $Q_0$  are plotted in Figure 2b and c, with comparison of the analytical results obtained from Eqs. (4) and (5). From these figures, we can observe that both methods show exactly the same solution for any load resistances and initial condition.

The second and a more complicated example is a parallel plate contact-mode triboelectric nanogenerator loaded with a resistor. The parameters used in this calculation are listed in Table 1. To be more accurate to the real experimental conditions, the top plate of this triboelectric nanogenerator is set to move in a simple harmonic mode as described below.

$$x = \frac{x_{\max}}{2} - \frac{x_{\max}}{2} \cos \left( \frac{\pi v}{x_{\max}} t \right) \quad (6)$$

From our previous analysis, the governing equation of this whole system combining the triboelectric nanogenerators and the resistor can be given as [16]:

$$R \frac{dQ}{dt} = V = - \frac{1}{C_{\text{TENG}}} Q + V_{\text{OC}} = - \frac{d_0 + x}{\epsilon_0 w l} Q + \frac{\sigma x}{\epsilon_0} \quad (7)$$

With the boundary condition of  $Q(t=0) = Q_0$ , the analytical results of output voltage and current can be given as [16]:

$$I(t) = - \frac{\sigma d_0}{R \epsilon_0} + \frac{2d_0 + x_{\max} - x_{\max} \cos((\pi v/x_{\max})t)}{2R w l \epsilon_0} \times \exp \left[ - \frac{1}{R w l \epsilon_0} \left( d_0 t + \frac{x_{\max}}{2} t - \frac{x_{\max}^2}{2\pi v} \sin \left( \frac{\pi v}{x_{\max}} t \right) \right) \right] \times \left\{ \sigma w l - Q_0 + \frac{\sigma d_0}{R \epsilon_0} \int_0^t \exp \left[ \frac{1}{R w l \epsilon_0} \left( d_0 z + \frac{x_{\max}}{2} z - \frac{x_{\max}^2}{2\pi v} \sin \left( \frac{\pi v}{x_{\max}} z \right) \right) \right] dz \right\} \quad (8)$$

$$V(t) = - \frac{\sigma d_0}{\epsilon_0} + \frac{2d_0 + x_{\max} - x_{\max} \cos((\pi v/x_{\max})t)}{2w l \epsilon_0} \times \exp \left[ - \frac{1}{R w l \epsilon_0} \left( d_0 t + \frac{x_{\max}}{2} t - \frac{x_{\max}^2}{2\pi v} \sin \left( \frac{\pi v}{x_{\max}} t \right) \right) \right] \times \left\{ \sigma w l - Q_0 + \frac{\sigma d_0}{R \epsilon_0} \int_0^t \exp \left[ \frac{1}{R w l \epsilon_0} \left( d_0 z + \frac{x_{\max}}{2} z - \frac{x_{\max}^2}{2\pi v} \sin \left( \frac{\pi v}{x_{\max}} z \right) \right) \right] dz \right\} \quad (9)$$

These equations are very complex, from which obtaining numerical outputs can only be achieved through complicated numerical calculation methods. As a comparison, a numerical output solution can be easily obtained from the simulator we built above, which is plotted in Figure 2d and e together with the analytical results from Eqs. (8) and (9). Similar to the above comparison, the simulator provides almost the same results with the analytical solution.

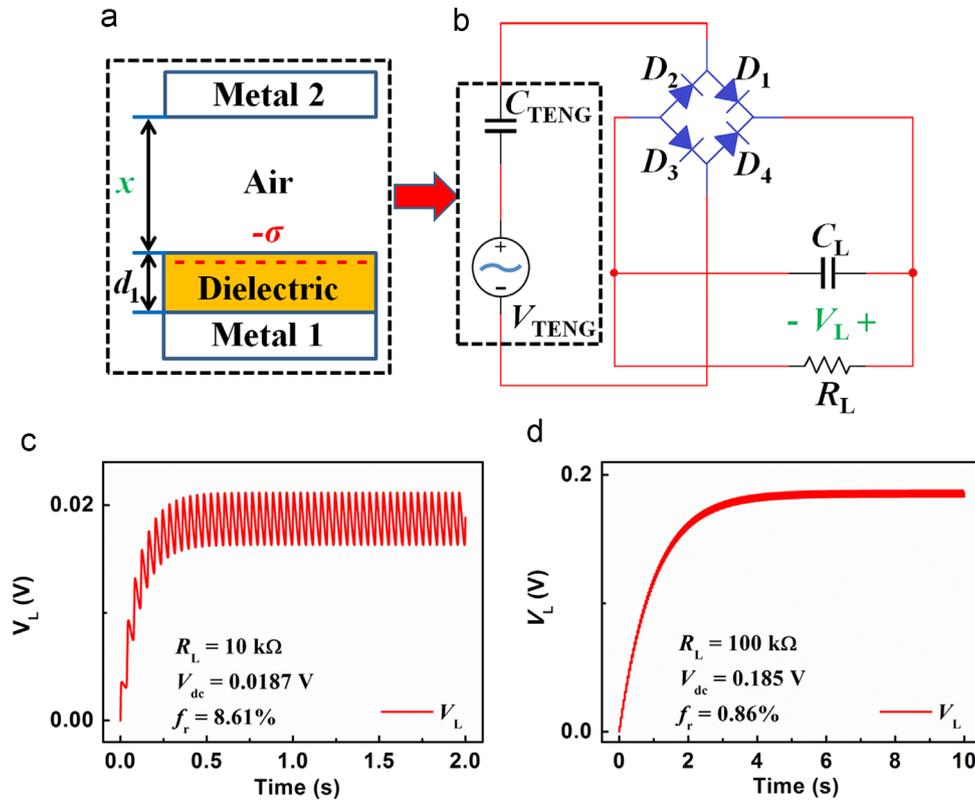
Above we provided two simple examples to show the validity of this newly-built simulator. In these cases, this integrated simulator can provide the correct results with a

much easier-to-use interface. However, the application of this simulator is much more beyond these two simple examples. In real applications, first, the load circuits are usually a combination of linear and nonlinear elements, including resistors, diodes (rectifiers), transistors, capacitors, inductors (transformers), and so forth. Besides, the real mechanical motion could be quite irregular. Moreover, the triboelectric nanogenerator itself is not so ideal and cannot be analytically represented. In such circumstances, utilizing the analytical method to solve non-linear differential equation sets is nearly an impossible task (See supporting information for a practically unsolvable example of the analytical method). Therefore, utilizing this new simulator is the only way to handle these practical problems and below we will provide an example that utilizing this simulator to design an on-chip power management system for triboelectric nanogenerators.

Because of the inherent capacitive characteristics [17], TENGs can only provide unstable AC voltage/current outputs, which is undesirable for most portable electronic applications. Therefore, a power management circuit is very necessary to convert these AC outputs from TENGs to DC outputs. Figure 3b shows a typical TENG power management circuit [21], including a diode bridge rectifier ( $D_1$  to  $D_4$ , parameters shown in Table S1) and a filter capacitor ( $C_L$ ). The resistive load is now represented by a load resistor  $R_L$ , which is in parallel connected with the filter capacitor. As an example, the TENG in this system is a parallel-plate contact-mode TENG with the parameter given in Table 1. Same as above, the top plate of this TENG is also under the same cosine motion. With the initial condition of  $Q(t=0) = Q_0 = 0$  and no charges on the filter capacitor, the output of the whole circuit can be simulated by the simulator.

The output voltage curves under  $C_L = 10 \mu\text{F}$  and  $R_L = 10 \text{ k}\Omega$ ,  $100 \text{ k}\Omega$  are shown in Figure 3c and d, respectively. Since there are no initial charges on the filter capacitor  $C_L$ , both of these two circumstances has a transition state, during which the capacitor is under charging. After several seconds, the transition state ends while the output goes to a periodic steady state, which has the same period as the mechanical motion. This periodic voltage signal is the steady state output signal, which has a DC component ( $V_{\text{DC}}$ ) and a ripple component ( $V_{\text{ripple}}$ ). The DC component of the output is dependent on the load resistance. For example, under  $R_L = 100 \text{ k}\Omega$  condition, the DC component of the output is  $0.185 \text{ V}$ , much larger than  $0.0187 \text{ V}$ , the DC component when  $R_L = 10 \text{ k}\Omega$ . Besides the DC component, there is also an undesirable ripple component in the output, which affects the stability of the output as a DC power source. The stability of the output under  $R_L = 100 \text{ k}\Omega$  condition is much better than that under  $R_L = 10 \text{ k}\Omega$  condition. Quantitatively, this stability is shown by the ripple factor ( $f_r$ ), defined as the ratio between the effective value of  $V_{\text{ripple}}$  and  $V_{\text{DC}}$ .  $f_r$  under  $R_L = 100 \text{ k}\Omega$  condition is  $0.86\%$ , which is much smaller than that under  $R_L = 10 \text{ k}\Omega$  condition ( $8.61\%$ ).

To systematically understand the influence of the filter capacitance and the load resistance on the output performance, the output under several filter capacitances and load resistances is calculated and the corresponding DC voltage, average power, and ripple factor are plotted in Figure 4a-c. As shown in Figure 4a,  $V_{\text{DC}}$  quickly increases with the increase of  $R_L$  when  $R_L$  is small. However, due to



**Figure 3** Output performance of the TENG system with power management circuits. (a) Structure of the TENG utilized in this calculation. (b) Equivalent circuits of the whole TENG system. (c) Real-time output voltage curve under  $C_L=10 \mu\text{F}$  and  $R_L=10 \text{ k}\Omega$  conditions. (d) Real-time output voltage curve under  $C_L=10 \mu\text{F}$  and  $R_L=100 \text{ k}\Omega$  conditions.

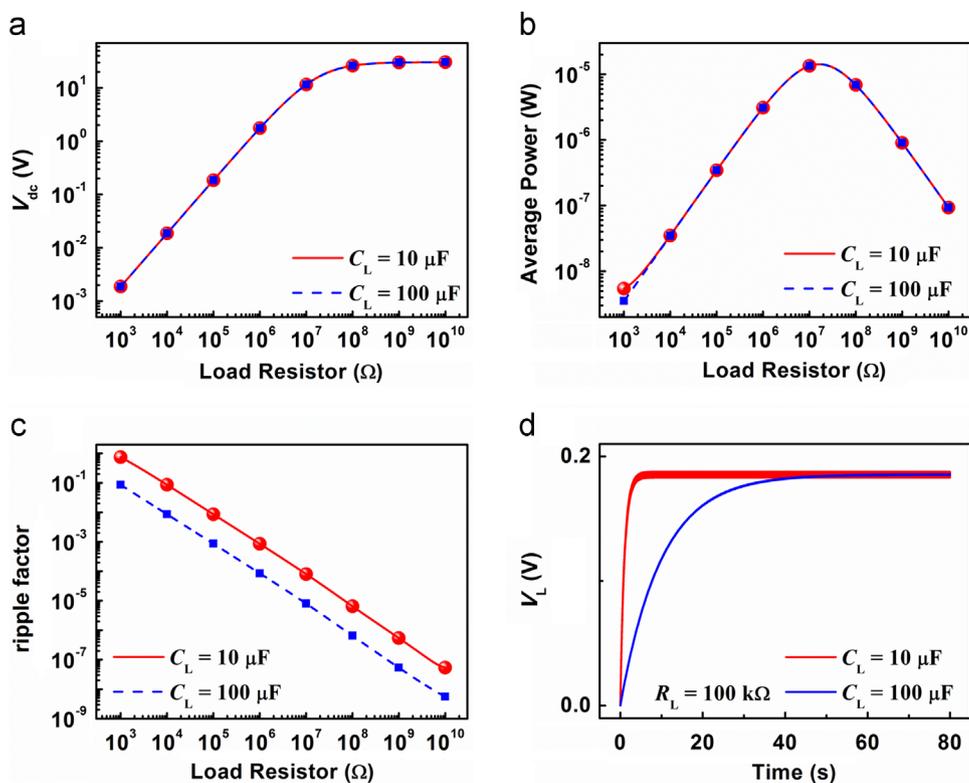
the limitation of the maximum voltage that the TENG can provide,  $V_{DC}$  gets to its saturation value when  $R_L$  is large enough.  $V_{DC}$  has a small dependence on  $C_L$  when  $R_L$  is very small. When  $R_L$  increases a little bit (larger than  $10 \text{ k}\Omega$  in this case),  $V_{ripple}$  becomes negligible comparing to  $V_{DC}$ . At the same time,  $V_{DC}$  becomes independent of  $C_L$ . This is because all of the capacitance shows infinite impedance at DC condition and the total impedance of the parallel between  $R_L$  and  $C_L$  is always  $R_L$ . Since  $V_{DC}$  only depends on  $R_L$  and has almost no dependence on  $C_L$ , the average power is also only dependent on  $R_L$ , as shown in Figure 4b. Same as the case in the simple resistive load, there also exists an optimum  $R_L$  at which the largest average DC power is reached, which is because of the impedance match between the load and the TENG. As  $C_L$  has almost no impact on  $V_{DC}$ , both the average power curve and the optimum  $R_L$  are also independent of  $C_L$ . However, different from  $V_{DC}$  and the average power,  $f_r$  depends on both  $R_L$  and  $C_L$ , and decreases when either  $R_L$  or  $C_L$  increases. This phenomenon results from the increase of the decay time constant of such load circuit, which equals to the product of  $R_L$  and  $C_L$ . Therefore, it seems that larger  $C_L$  is good for the whole performance of the circuit because it has no influence on  $V_{DC}$  but can largely reduce  $f_r$ . However, larger  $C_L$  will increase the length of the transition state and make it more difficult to reach the steady state, when the whole circuits begin to function. As shown in Figure 4d, for the same  $R_L$ , it takes less than 5 s to reach steady state when  $C_L$  is only  $10 \mu\text{F}$  while it takes about 50 s to reach steady state when  $C_L$  is  $100 \mu\text{F}$ . This is

because larger capacitance will require larger amount of charges to reach the same final voltage.

From the discussion above, we can obtain the following strategy for the design of the power management system. First, simulate the whole system with a relative large  $C_L$  and different  $R_L$  to obtain the optimum resistance. Second, setting  $R_L$  at the optimum resistance, simulate the whole system with different  $C_L$  and calculate the  $f_r$ - $C_L$  curve. Third, from the requirement of real application on  $f_r$  and the calculated  $f_r$ - $C_L$  curve, choose a minimum  $C_L$  that meets the requirement for  $f_r$ . Finally, from the optimum resistance and the load resistance for the real application, design a DC-DC convertor to realize load adaption. From the above procedures, a power management system for TENG can be easily designed.

## Conclusion

In summary, the first equivalent circuit model was proposed and the first integrated simulator for triboelectric nanogenerator systems is built from this equivalent circuit model and validated through comparison with the analytical results. Utilizing this simulator, we analyzed the performance of a whole system containing TENG and power management circuits. The DC voltage output is only affected by the load resistor and is almost independent of the filter capacitor. Increasing the load resistor can help increase the DC voltage output but there exists an optimum



**Figure 4** Optimization of the performance of the integrated TENG system. (a) DC voltage under different load resistances and filter capacitances. (b) Average output power under different load resistances and filter capacitances. (c) Ripple factor under different load resistances and filter capacitances. (d) Real-time output voltage curve under 100 k $\Omega$  load resistance and different filter capacitances.

load resistance at which the energy delivered gets its maximum. The ripple factor of the output is determined by the product of the load resistance and the filter capacitance. Increasing either of them can reduce the ripple factor, but large capacitor will lead to a longer transition state. Based on the above conclusion, we provide the design flow for such power management system. This new simulation method is a standard tool and method of TENG simulation, which can be applied to any TENG systems. It will greatly facilitate the future design and optimization of TENGs. In addition, the discussion of the power management circuit can serve as a guide in next-step experiments for real applications.

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## Appendix A. Supporting information

Supplementary data associated with this article can be found in the online version at <http://dx.doi.org/10.1016/j.nanoen.2014.05.018>.

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tion Award by the Minister of State for Science and Technology in 1998, Academic Award of the Ceramic Society of Japan in 1997, Seto Award of Electron Microscopy Society of Japan in 1994, Science and Technology Accomplishment Award by the Minister of State for Science and Technology in 1994. In 2002, he was chosen as one of the "Top Thirty Key Persons in Nanotechnology" in Japan by the scientific journal, "Nikkei Science". He is appointed as adjunct member of the Science Council of Japan (2006). He is now a Fellow of American Ceramic Society and an Editor-in-Chief of Journal of Electron Microscopy.



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He coined and pioneered the field of piezotronics and piezo-phototronics by introducing piezoelectric potential gated charge transport process in fabricating new electronic and optoelectronic devices. This historical breakthrough by redesign CMOS transistor has important applications in smart MEMS/NEMS, nanorobotics, human-electronics interface and sensors. Dr. Wang's entire publications have been cited for over 60,000 times. The H-index of his publications is 129.